

<b>Notice of References Cited</b>	Application/Control No. 10/594,495		Applicant(s)/Patent Under Reexamination OHMI ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,640,689 A	02-1972	Glaski et al.	428/627
*	B	US-5,019,531 A	05-1991	Awaya et al.	438/605
*	C	US-5,054,420 A	10-1991	Raghavan et al.	118/715
*	D	US-5,068,871 A	11-1991	Uchida et al.	373/17
*	E	US-5,071,678 A	12-1991	Grybowski et al.	427/253
*	F	US-5,160,544 A	11-1992	Garg et al.	118/724
*	G	US-5,180,436 A	01-1993	Ueda et al.	118/723MR
*	H	US-5,252,131 A	10-1993	Kiyama et al.	118/719
*	I	US-5,399,199 A	03-1995	Kiyama et al.	118/719
*	J	US-5,575,853 A	11-1996	Arami et al.	118/708
*	K	US-6,143,081 A	11-2000	Shinriki et al.	118/719
*	L	US-6,202,591 B1	03-2001	Witzman et al.	118/723VE
*	M	US-6,334,928 B1	01-2002	Sekine et al.	156/345.29

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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	S					
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#### NON-PATENT DOCUMENTS

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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0136516 A1	07-2003	Kim et al.	156/345.33
*	B	US-6,616,973 B1	09-2003	Nguyen et al.	427/255.38
*	C	US-6,782,907 B2	08-2004	Kawasaki et al.	137/12
*	D	US-6,863,019 B2	03-2005	Shamouilian et al.	118/723R
*	E	US-7,078,072 B1	07-2006	Hiraga et al.	427/133
*	F	US-7,132,128 B2	11-2006	Brcka, Jozef	427/248.1
*	G	US-7,156,950 B2	01-2007	Kim et al.	156/345.48
*	H	US-7,481,889 B2	01-2009	Yamazaki et al.	118/726
*	I	US-7,524,481 B2	04-2009	Tenne et al.	423/561.1
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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